MT1139N5

N-Channel Enhancement Mode Field Effect Transistor

Product Summary

- $V_{DS} = 100V$
- $I_D = 110A (V_{GS} = 10V)$
- R DS(ON) < $4.6 \, \text{m} \, \Omega$ @V_{GS} = $10 \, \text{V}$

The MT1139N5 uses Super Trench technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{DS(ON)}$ and Q_g . This device is ideal for high-frequency switching and synchronous rectification.

- Excellent gate charge x R_{DS(on)} product(FOM)
- Very low on-resistance R_{DS(on)}
- 150 °C operating temperature
- · Pb-free lead plating

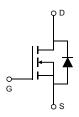
Application

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification

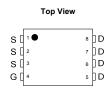


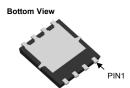
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Simplified Schematic



MARKING DIAGRAM & PIN ASSIGNMENT





DFN5X6-8L

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MT1139N5	MT1139N5	DFN5X6-8L		-	5,000

Absolute Maximum Ratings (T_C=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	100	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous (Package Limited) (T _C =25°C)	I _D	110	А
Drain Current-Continuous(T _C =100°C)	I _D (100℃)	70	Α
Pulsed Drain Current	I _{DM}	160	Α
Maximum Power Dissipation	P _D	85	W
Derating factor		0.84	W/℃
Single pulse avalanche energy (Note 5)	E _{AS}	198	mJ
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 150	$^{\circ}$

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Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2)	R _{eJC}	1.2	°C/W
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Electrical Characteristics (T_C=25 ℃ unless otherwise noted)

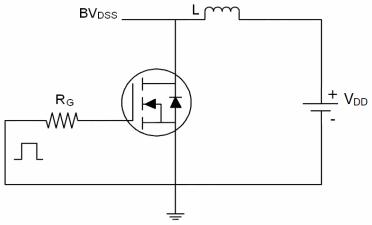
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics				•		
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	100		-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)				•		
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2	3	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =30A	-	3.6	4.6	mΩ
Forward Transconductance	g FS	V _{DS} =10V,I _D =30A	40	-	-	S
Dynamic Characteristics (Note4)				•		
Input Capacitance	C _{lss}	\/ -50\/\/ -0\/	-	1600	-	PF
Output Capacitance	Coss	V_{DS} =50V, V_{GS} =0V, F=1.0MHz	-	100	-	PF
Reverse Transfer Capacitance	C _{rss}	r=1.0MHZ	-	29	-	PF
Switching Characteristics (Note 4)				•		
Turn-on Delay Time	t _{d(on)}		-	12	-	nS
Turn-on Rise Time	t _r	V_{DD} =50 V , I_D =30 A	-	45	-	nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =10V, R_{G} =4.7 Ω	-	31	-	nS
Turn-Off Fall Time	t _f		-	10	-	nS
Total Gate Charge	Qg	\/ -50\/ -204	-	48		nC
Gate-Source Charge	Q _{gs}	V_{DS} =50V, I_{D} =30A, V_{GS} =10V	-	15		nC
Gate-Drain Charge	Q _{gd}	V _{GS} -10V	-	8		nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =60A	-		1.2	V
Diode Forward Current (Note 2)	Is		-	-	60	Α
Reverse Recovery Time	t _{rr}	$T_J = 25^{\circ}C, I_F = I_S$	-	55		nS
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-	93		nC

Notes:

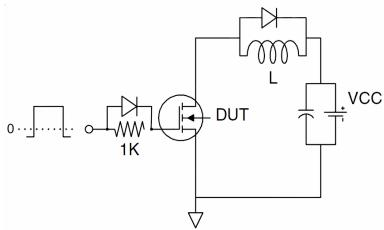
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS condition : Tj=25 $^{\circ}\text{C}$,VDD=50V,VG=10V,L=0.5mH,Rg=25 Ω

Test Circuit

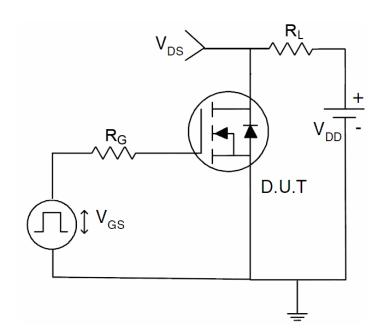
1) E_{AS} test Circuit



2) Gate charge test Circuit



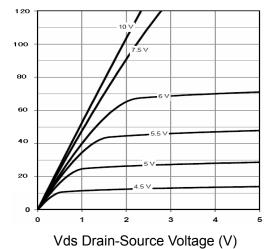
3) Switch Time Test Circuit



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Typical Electrical and Thermal Characteristics



Ip- Drain Current (A)

ID- Drain Current (A)

Figure 1 Output Characteristics

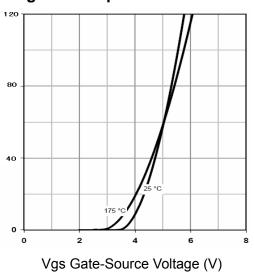


Figure 2 Transfer Characteristics

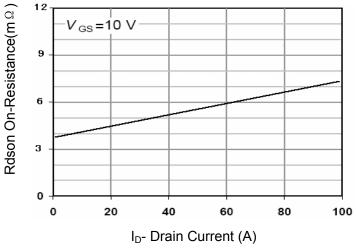
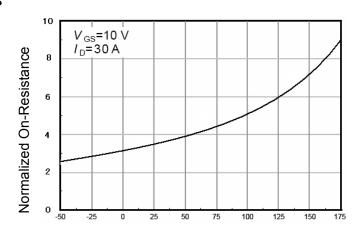


Figure 3 Rdson- Drain Current



 T_J -Junction Temperature (°C) Figure 4 Rdson-JunctionTemperature

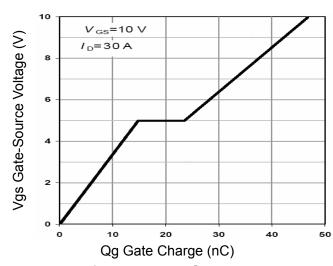


Figure 5 Gate Charge

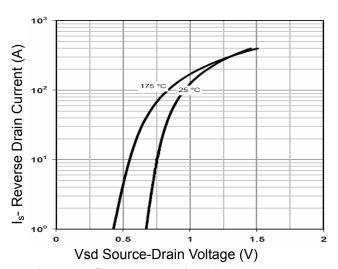


Figure 6 Source- Drain Diode Forward

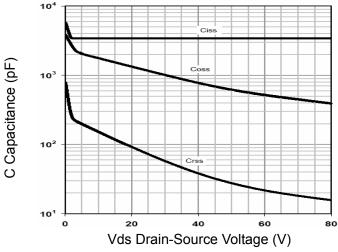


Figure 7 Capacitance vs Vds

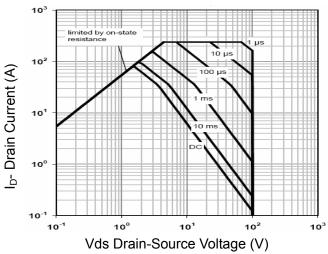


Figure 8 Safe Operation Area

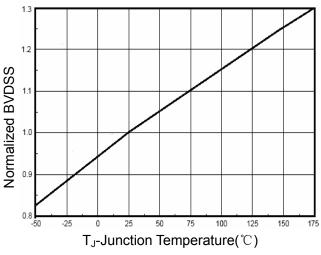


Figure 9 BV_{DSS} vs Junction Temperature

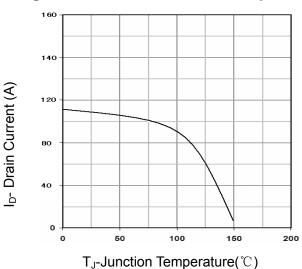
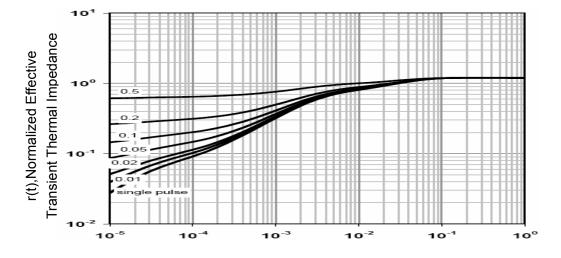


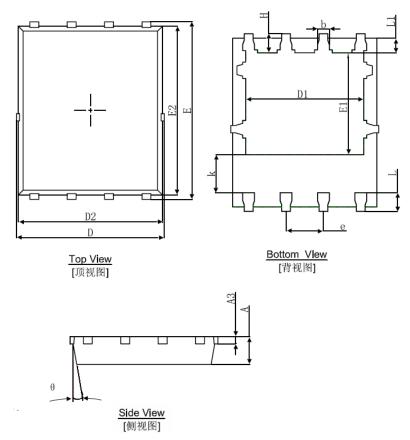
Figure 10 Current De-rating



Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance

DFN5X6-8L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min.	Max.	Min.	Max.	
Α	0.900	1.000	0.035	0.039	
A3	0.254	4REF.	0.010	REF.	
D	4.944	5.096	0.195	0.201	
E	5.974	6.126	0.235	0.241	
D1	3.910	4.110	0.154	0.162	
E1	3.375	3.575	0.133	0.141	
D2	4.824	4.976	0.190	0.196	
E2	5.674	5.826	0.223	0.229	
k	1.190	1.390	0.047	0.055	
b	0.350	0.450	0.014	0.018	
е	1.270TYP.		0.050	TYP.	
L	0.559	0.711	0.022	0.028	
L1	0.424	0.576	0.017	0.023	
Н	0.574	0.726	0.023	0.029	
θ	8°	12°	8°	12°	

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